

<b>Search Notes</b> 	<b>Application/Control No.:</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/623,418	OHKAWA, NARUMI
	<b>Examiner</b>	<b>Art Unit</b>
	Nhan T. Tran	2622

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search - see search history printout		10/1/2007	NT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) (text search - see search history printout)	10/1/2007	NT
348/294-324 (text search - see search history printout)	2/28/2007	NT
257/290-292 (text search - see search history printout)	3/1/2007	NT
250/208.1 (text search - see search history printout)	3/1/2007	NT
Search all classes 348, 257 and 250	3/1/2007	NT
Inventorship search - see search history printout	10/1/2007	NT